## Notice of References Cited Application/Control No. 10/803,714 Examiner Naum B. Levin Applicant(s)/Patent Under Reexamination KELLER ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,202,841 A	04-1993	Tani, Takahiro	716/5
*	В	US-5,446,676 A	08-1995	Huang et al.	703/19
*	С	US-5,548,539 A	08-1996	Vlach et al.	703/6
*	D	US-5,553,008 A	09-1996	Huang et al.	703/14
*	Ε	US-5,677,856 A	10-1997	Tani, Takahiro	703/13
*	F	US-5,691,910 A	11-1997	Thodiyil, John A.	702/60
*	G	US-5,703,798 A	12-1997	Dhar, Sanjay	703/14
*	н	US-5,880,967 A	03-1999	Jyu et al.	716/6
*	ı	US-6,249,898 B1	06-2001	Koh et al.	716/4
*	J	US-6,574,760 B1	06-2003	Mydill, Marc	714/724
*	К	US-6,728,939 B2	04-2004	Johannsen, Peer	716/5
*	L	US-6,748,572 B2	06-2004	Fujine, Eiji	716/5
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s			•		
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.